# Numerical Demonstration of Single－Electron Inverter with Input Discretizer <br> Dept．Engineering Science，The Univ．of Electro－Communications（UEC Tokyo） <br> Tran Thi Thu Huong，Hiroshi Shimada，Yoshinao Mizugaki <br> E－mail：huongtran＠uec．ac．jp 

## 1．Introduction

Single－electron（SE）four－junction inverter（FJI） ［1］is very attractive to low power dissipation and high density integration applications．In this paper， we propose to employ an SE input discretizer（ID） ［2］for improvement in reliable operation．

## 2．Characteristics of a SE ID－FJI

Fig．1．shows the diagram of an ID－FJI．The idea to make the switch of a FJI sharper is the utilization of discrete charge shift in the ID．Monte－Carlo simulation was executed with following conditions． ID： $\mathrm{J}_{0}(1 \mathrm{aF}, 100 \mathrm{k} \Omega), \mathrm{C}=72 \mathrm{aF} ;$ FJI： $\mathrm{J}_{1} \& \mathrm{~J}_{4}(1 \mathrm{aF}$, $100 \mathrm{k} \Omega) \mathrm{J}_{2} \& \mathrm{~J}_{3}(2 \mathrm{aF}, 50 \mathrm{k} \Omega), \mathrm{C}_{\mathrm{g} 1}=\mathrm{C}_{\mathrm{g} 2}=8 \mathrm{aF}$, $\mathrm{C}_{\mathrm{b} 1}=\mathrm{C}_{\mathrm{b} 2}=7 \mathrm{aF} ; \mathrm{V}_{\mathrm{s}}=6.7 \mathrm{mV}, \mathrm{C}_{\text {out }}=1 \mathrm{fF}, \mathrm{T}=0 \mathrm{~K}$ ， no co－tunneling．

The simulated input－output $\left(\mathrm{V}_{\text {in }}-\mathrm{V}_{\text {out }}\right)$ characteristics of the ID－FJI are shown in Fig． 2. Sharper（negatively infinite）switching is demonstrated in comparison with an FJI whose voltage gain is－3．7．This result can be explained by characteristics of charge $\mathrm{Q}_{0}$ at the center island of ID（Fig．2）， $\mathrm{N}=\mathrm{Q}_{0}$ e ．In the middle of the input signal $\mathrm{V}_{\mathrm{in}} \approx 3.35 \mathrm{mV}$ ，there is a tunnel from $\mathrm{N}=1$ to $N=2$ ，resulting in a sharp switching of the output voltage at this point．
The device can work well if we connect them with each other（Fig．3）．Furthermore，from the $2^{\text {nd }}$ output voltage，its amplitude is absolutely constant．

## 3．Conclusion

The ID－FJI operates absolutely reliably in the switch region when it works alone，and in series．

## References

［1］J．R．Tucker，J．Apple．Phys．， 72 （1992） 4399.
［2］Y．Mizugaki，et al．，IEEE Trans．Nanotech．， 7 （2008） 601.


Fig．1．Diagram of a SE ID－FJI


Fig．2．Characteristics of a solo FJI，and an ID－FJI．


Fig．3．Output signals of 3 ID－FJIs in series．

